

# PTF 10119

## GOLDMOS® Field Effect Transistor

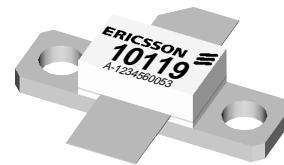
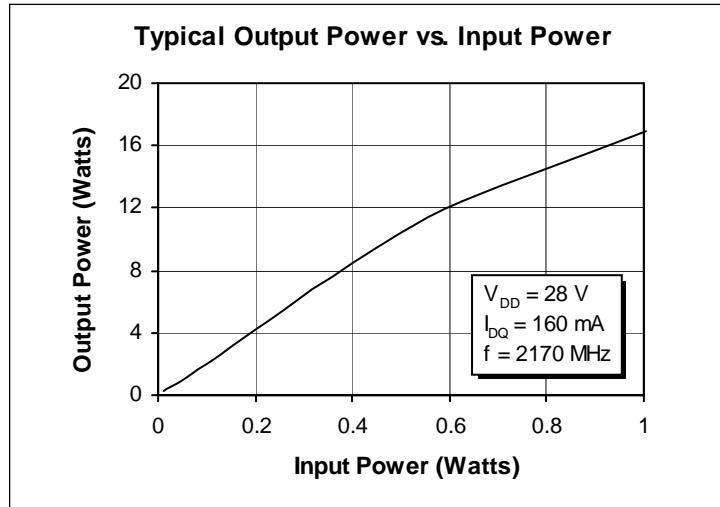
### 12 Watts, 2.1–2.2 GHz

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#### Description

The PTF 10119 is a 12-watt GOLDMOS FET intended for WCDMA applications from 2.1 to 2.2 GHz. It operates at 43% efficiency with 11 dB typical gain. Nitride surface passivation and full gold metallization ensure excellent device lifetime and reliability.

- **INTERNALLY MATCHED**
- Performance at 2.17 GHz, 28 Volts
  - Output Power = 12 Watts Min
  - Power Gain = 11 dB Typ
  - Efficiency = 43% Typ @ P-1dB
- Full Gold Metallization
- Silicon Nitride Passivated
- Back Side Common Source
- Excellent Thermal Stability
- 100% lot traceability



Package 20222

#### RF Specifications (100% Tested)

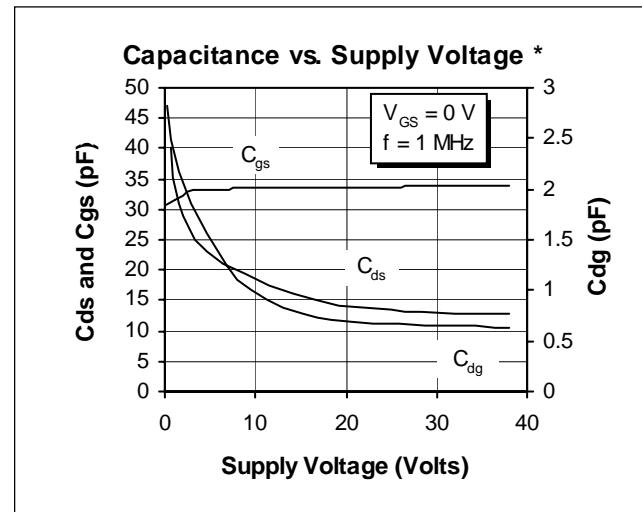
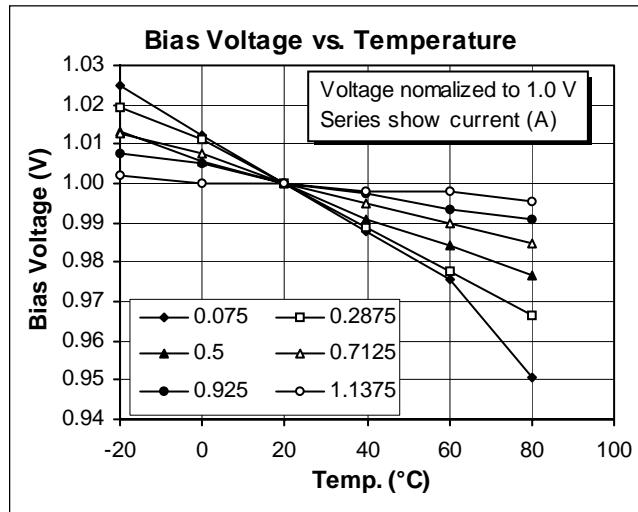
Characteristic	Symbol	Min	Typ	Max	Units
<b>Gain</b> (V <sub>DD</sub> = 28 V, P <sub>OUT</sub> = 3 W, I <sub>DQ</sub> = 160 mA, f = 2.11, 2.17 GHz)	G <sub>ps</sub>	10	11	—	dB
<b>Power Output at 1 dB Compressed</b> (V <sub>DD</sub> = 28 V, I <sub>DQ</sub> = 160 mA, f = 2.17 GHz)	p-1dB	12	14	—	Watts
<b>Drain Efficiency</b> (V <sub>DD</sub> = 28 V, P <sub>OUT</sub> = 12 W, I <sub>DQ</sub> = 160 mA, f = 2.17 GHz)	η <sub>D</sub>	30	43	—	%
<b>Load Mismatch Tolerance</b> (V <sub>DD</sub> = 28 V, P <sub>OUT</sub> = 12 W, I <sub>DQ</sub> = 160 mA, f = 2.17 GHz — all phase angles at frequency of test)	Ψ	—	—	10:1	—

**Electrical Characteristics** (100% Tested)

Characteristic	Conditions	Symbol	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 50 \text{ mA}$	$V_{(BR)DSS}$	65	—	—	Volts
Zero Gate Voltage Drain Current	$V_{DS} = 26 \text{ V}$ , $V_{GS} = 0 \text{ V}$	$I_{DSS}$	—	—	1.0	$\mu\text{A}$
Gate Threshold Voltage	$V_{DS} = 10 \text{ V}$ , $I_D = 75 \text{ mA}$	$V_{GS(\text{th})}$	3.0	—	5.0	Volts
Forward Transconductance	$V_{DS} = 10 \text{ V}$ , $I_D = 2 \text{ A}$	$g_f$	—	0.8	—	Siemens

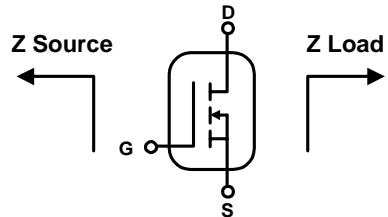
**Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	65	Vdc
Gate-Source Voltage	$V_{GS}$	$\pm 20$	Vdc
Operating Junction Temperature	$T_J$	200	$^{\circ}\text{C}$
Total Device Dissipation Above 25°C derate by	$P_D$	55 0.31	Watts W/ $^{\circ}\text{C}$
Storage Temperature Range	$T_{STG}$	-40 to +150	$^{\circ}\text{C}$
Thermal Resistance ( $T_{CASE} = 70^{\circ}\text{C}$ )	$R_{\theta JC}$	3.2	$^{\circ}\text{C}/\text{W}$

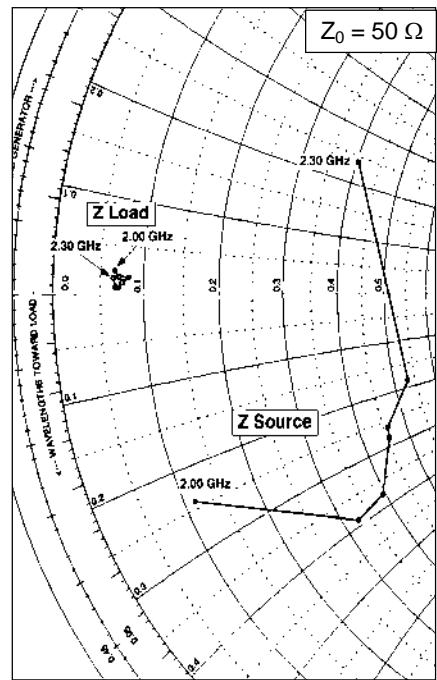
**Typical Performance**

\*This part is internally matched. Measurements of the finished product will not yield these figures.

**Impedance Data**

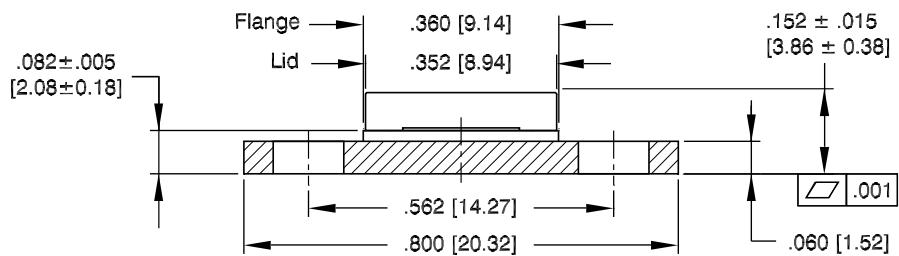
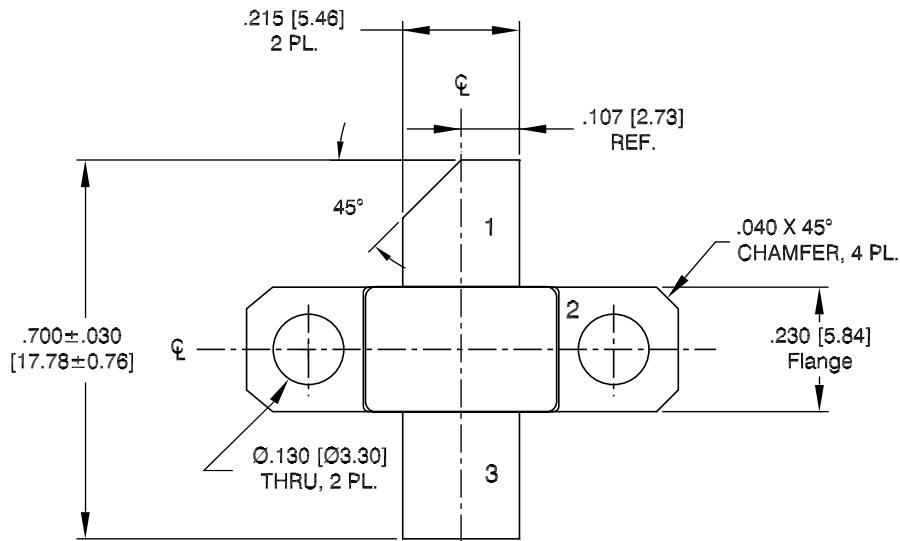
 V<sub>DS</sub> = 28 V, P<sub>OUT</sub> = 12 W, I<sub>DQ</sub> = 160 mA


Frequency GHz	Z Source Ω		Z Load Ω	
	R	jX	R	jX
2.00	5.7	-12.11	3.30	1.21
2.10	16.4	-19.50	3.55	0.92
2.12	19.7	-18.82	4.12	0.88
2.15	22.8	-14.14	3.75	0.62
2.17	23.0	-13.15	3.53	0.34
2.20	26.6	-9.28	3.32	0.38
2.30	20.2	12.03	3.23	0.84



## Case Outline Specifications

Case 20222



Unless otherwise specified  
all tolerances  $\pm .003$  [ $\pm 0.08$ ]

Pins: 1. Drain 2. Source 3. Gate  
Lead Thickness:  $.004 \pm .001$ " [0.10±0.03mm]